

<b>Notice of References Cited</b>	Application/Control No. 10/658,272	Applicant(s)/Patent Under Reexamination KIM ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,223,500	05-2007	Noh et al.	429/307
*	B	US-4,489,145	12-1984	Abraham et al.	429/336
*	C	US-4,670,363	06-1987	Whitney et al.	429/328
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 62-160671	07-1987	Japan	Osaki et al.	
	O	JP 4-56079	02-1992	Japan	Okazaki et al.	
	P	JP 2002-359002	12-2002	Japan	Takehara et al.	
	Q				Patent, translation and abstract	
	R	JP 2002-124298	04-2002	Japan	Hamamoto et al.	
	S				Patent, translation and abstract	
	T	JP 8-138735	05-1996	Japan	Yamamoto et al.	

#### NON-PATENT DOCUMENTS (Patent, translation and abstract)

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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